## **<u>MOSFET</u> – Power, Dual N-Channel** 40 V, 11.7 mΩ, 36 A

#### Features

- Small Footprint (5x6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- NVMFD5C470NWF Wettable Flank Option for Enhanced Optical Inspection
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant



### **ON Semiconductor®**

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V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
40 V	11.7 m $\Omega$ @ 10 V	36 A

		/ise noted)	C unless otherw	(T <sub>J</sub> = 25°0	MAXIMUM RATINGS		
Unit	Value	Symbol	Parameter				
V	40	V <sub>DSS</sub>	Drain-to-Source Voltage				
V	±20	V <sub>GS</sub>		9	Gate-to-Source Voltage		
А	36	Ι <sub>D</sub>	$T_{C} = 25^{\circ}C$	Steady State	Continuous Drain Current $R_{\theta JC}$ (Notes 1, 2, 3)		
	25		$T_{C} = 100^{\circ}C$				
W	28	PD	T <sub>C</sub> = 25°C		Power Dissipation		
	14		T <sub>C</sub> = 100°C		$R_{\theta JC}$ (Notes 1, 2)		
А	11.7	I <sub>D</sub>	T <sub>A</sub> = 25°C	Steady State	Continuous Drain		
	8.3		$T_A = 100^{\circ}C$		Current R <sub>θJA</sub> (Notes 1, 2, 3)		
W	3.1	PD	T <sub>A</sub> = 25°C		Power Dissipation		
	1.5		T <sub>A</sub> = 100°C		$R_{\theta JA}$ (Notes 1 & 2)		
А	108	I <sub>DM</sub>	°C, t <sub>p</sub> = 10 μs	T <sub>A</sub> = 25	Pulsed Drain Current		
°C	–55 to + 175	T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature				
А	23	I <sub>S</sub>	ource Current (Body Diode)				
mJ	49	E <sub>AS</sub>	Single Pulse Drain-to-Source Avalanche Energy (T <sub>J</sub> = 25°C, $I_{L(pk)}$ = 2 A)				
°C	260	ΤL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)				
	3.1 1.5 108 -55 to + 175 23 49	I <sub>DM</sub> T <sub>J</sub> , T <sub>stg</sub> Is E <sub>AS</sub>	$T_{A} = 25^{\circ}C$ $T_{A} = 100^{\circ}C$ $T_{A} = 10 \ \mu s$ The matrix is the matrix of the matrix of the matrix is the matrix of t	State $T_A = 25^{\circ}$ Storage T iode) Source Ava $j = 2 A^{\circ}$ oldering P	$\begin{array}{l} (\text{Notes 1, 2, 3}) \\ \text{Power Dissipation} \\ \text{R}_{\theta JA} \ (\text{Notes 1 \& 2}) \\ \\ \text{Pulsed Drain Current} \\ \text{Operating Junction and} \\ \\ \text{Source Current (Body D} \\ \\ \text{Single Pulse Drain-to-S} \\ \\ \text{Energy (T_J = 25^{\circ}\text{C}, I_{L(pk)} \\ \\ \\ \text{Lead Temperature for S} \end{array}$		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

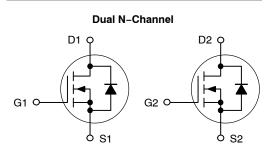
#### THERMAL RESISTANCE MAXIMUM RATINGS

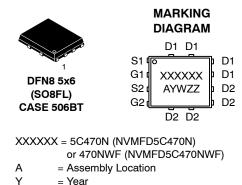
Parameter	Symbol	Value	Unit
Junction-to-Case - Steady State	$R_{\theta JC}$	5.3	°C/W
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	49	

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.

2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.

3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.





- = Year
- W = Work Week
- ΖZ = Lot Traceability

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 5 of this data sheet.

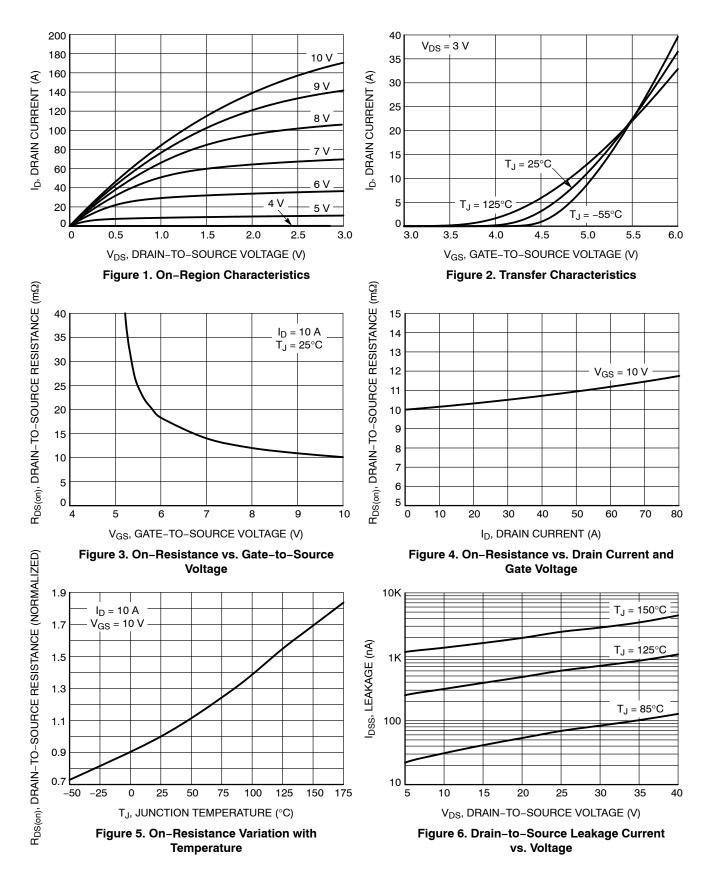
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#### **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = $25^{\circ}$ C unless otherwise specified)

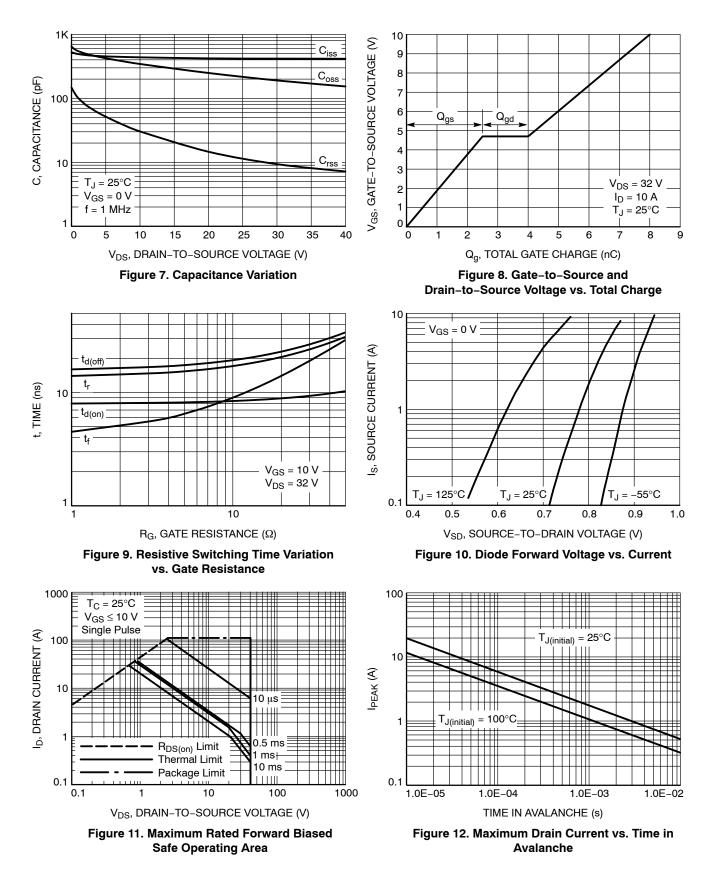
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS}$ = 0 V, I <sub>D</sub> = 250 $\mu$ A		40			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> / T <sub>J</sub>				24		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$ \begin{array}{c} V_{GS} = 0 \ V, \\ V_{DS} = 40 \ V \end{array} \qquad \begin{array}{c} T_{J} = 25 \ ^{\circ}C \\ \hline T_{J} = 125 \ ^{\circ}C \end{array} $				10	
						100	μΑ
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = 20 V				100	nA
ON CHARACTERISTICS (Note 4)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_{E}$	<sub>D</sub> = 250 μA	2.5		3.5	V
Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				-6.0		mV/°
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 10 A		9.75	11.7	mΩ
CHARGES, CAPACITANCES & GATE	RESISTANCE			-	-		
Input Capacitance	C <sub>ISS</sub>				420		
Output Capacitance	C <sub>OSS</sub>	V <sub>GS</sub> = 0 V, f = 1 M	Hz, V <sub>DS</sub> = 25 V		210		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>				11		1
Total Gate Charge	Q <sub>G(TOT)</sub>				8.0		1
Threshold Gate Charge	Q <sub>G(TH)</sub>				1.6		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS}$ = 10 V, $V_{DS}$ = 32 V; $I_{D}$ = 10 A			2.5		nC
Gate-to-Drain Charge	Q <sub>GD</sub>				1.5		
Plateau Voltage	V <sub>GP</sub>				4.7		V
SWITCHING CHARACTERISTICS (Note	e 5)						
Turn-On Delay Time	t <sub>d(ON)</sub>				8.0		<u> </u>
Rise Time	tr	Vcs = 10 V. V	ne = 32 V.		14		1
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$\label{eq:VGS} \begin{array}{l} V_{GS} = 10 \; V, \; V_{DS} = 32 \; V, \\ I_{D} = 10 \; A, \; R_{G} = 1.0 \; \Omega \end{array}$			16		ns
Fall Time	t <sub>f</sub>				4.5		
DRAIN-SOURCE DIODE CHARACTER	RISTICS						
Forward Diode Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0 V,	$T_J = 25^{\circ}C$		0.9	1.2	
		$I_{\rm S} = 10 \rm{A}$	T <sub>J</sub> = 125°C		0.8		- V
Reverse Recovery Time	t <sub>RR</sub>	V <sub>GS</sub> = 0 V, dIS/dt = 100 A/µs, I <sub>S</sub> = 10 A			20		1
Charge Time	t <sub>a</sub>				9.0		ns
Discharge Time	t <sub>b</sub>				10		1
Reverse Recovery Charge	Q <sub>RR</sub>				7.5		nC

4. Pulse Test: pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2%. 5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



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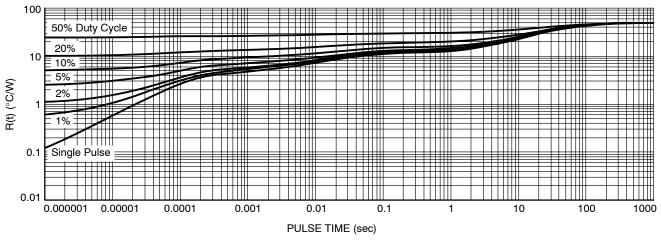


Figure 13. Thermal Response

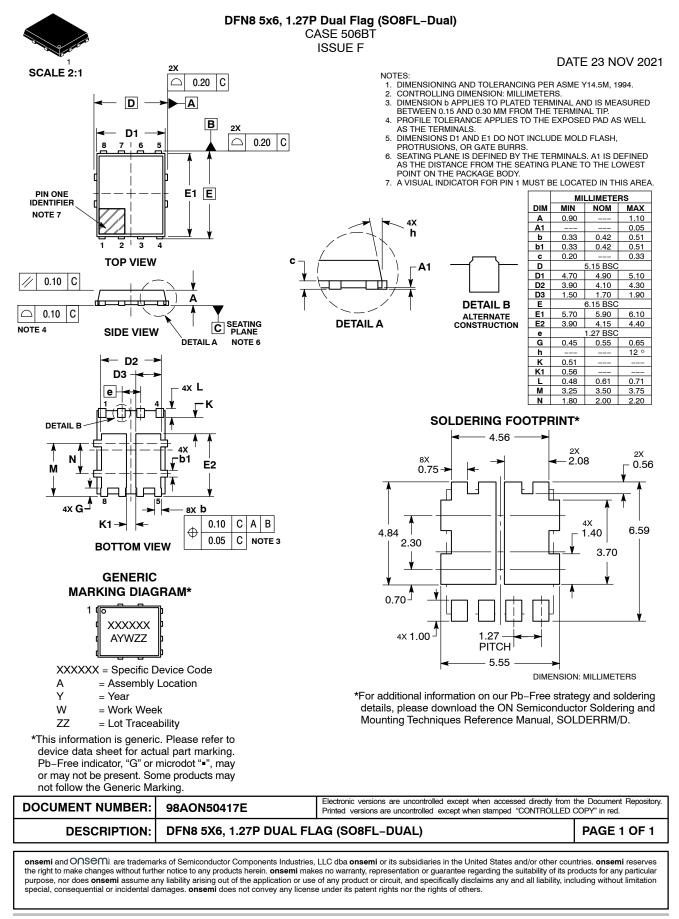
#### **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NVMFD5C470NT1G	5C470N	DFN8 (Pb–Free)	1500 / Tape & Reel
NVMFD5C470NWFT1G	470NWF	DFN8 (Pb-Free, Wettable Flanks)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS

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